
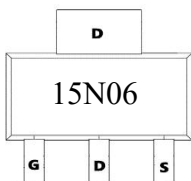
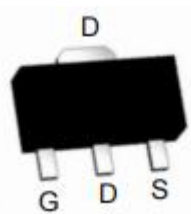
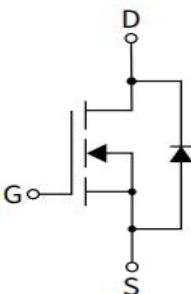




Features <ul style="list-style-type: none"> ➤ Super Low Gate Charge ➤ Green Device Available ➤ Excellent Cdv/dt effect decline ➤ Advanced high cell density Trench technology 	<i>Bvdss</i>	<i>Rdson</i>	<i>ID</i>
	60V	28mΩ	15A
	Application <ul style="list-style-type: none"> ➤ PWM applications ➤ Load Switch ➤ Power management 		
Package			
			
Marking and pin assignment	SOT89-3L top view	Schematic diagram	

Package Marking and Ordering Information

Device Marking	Device	Device Package	Quantity
15N06	15N06Q	SOT89-3L	1000

Absolute Maximum Ratings ($T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current, $V_{GS}@10V^1$	$I_D@T_A=25^\circ\text{C}$	15	A
	$I_D@T_A=70^\circ\text{C}$	7.5	A
Pulsed Drain Current ²	I_{DM}	22	A
Single Pulsed Avalanche Energy ³	EAS	22	mJ
Avalanche Current	I_{AS}	23	A
Total Power Dissipation ⁴	P_D	1.5	W
Operating and Storage Temperature Range	T_J, T_{STG}	-55 ~ 150	$^\circ\text{C}$

Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-to-Case ¹	$R_{\theta JC}$	25	$^\circ\text{C/W}$
Thermal Resistance Junction-to-Ambient ¹	$R_{\theta JA}$	85	$^\circ\text{C/W}$



Ordering Information

Ordering Number	Package	Pin Assignment			Packing
Halogen Free		G	D	S	
HL15N06Q	SOT89-3L	1	2	3	Tape Reel

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
Drain-Source Breakdown Voltage	$V_{B_{DSS}}$	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	60	-	-	V	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=60\text{V}, V_{GS}=0\text{V}$	-	-	1	μA	
Gate to Body Leakage Current	I_{GSS}	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$	-	-	± 100	nA	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu\text{A}$	1	1.6	2.5	V	
Static Drain-Source On-Resistance ³	$R_{DS(on)}$	$V_{GS}=10\text{V}, I_D=15\text{A}$	-	40	49	m Ω	
		$V_{GS}=4.5\text{V}, I_D=10\text{A}$	-	45	63		
Input Capacitance	C_{iss}	$V_{DS}=25\text{V}, V_{GS}=0\text{V},$ $f=1\text{MHz}$	-	825	-	pF	
Output Capacitance	C_{oss}		-	49	-		
Reverse Transfer Capacitance	C_{rss}		-	41	-		
Total Gate Charge	Q_g	$V_{DS}=30\text{V}, I_D=4.5\text{A},$ $V_{GS}=10\text{V}$	-	14	-	nC	
Gate-Source Charge	Q_{gs}		-	2.9	-		
Gate-Drain Charge	Q_{gd}		-	5.2	-		
Turn-On Delay Time	$t_{d(on)}$	$V_{GS}=10\text{V}, V_{DS}=30\text{V},$ $R_G=3\Omega, I_D=2\text{A},$ $V_L=6.7\Omega$	-	5	-	ns	
Turn-On Rise Time	t_r		-	2.6	-		
Turn-Off Delay Time	$T_{d(off)}$		-	16.1	-		
Turn-Off Fall Time	t_f		-	2.3	-		
Maximum Continuous Drain to Source Diode Forward Current		I_S	-	-	10	A	
Maximum Pulsed Drain to Source Diode Forward Current		I_{SM}	-	-	30	A	
Drain to Source Diode Forward Voltage	$V_{GS}=0\text{V}, I_S=15\text{A}$		V_{SD}	-	-	1.2	V
Body Diode Reverse Recovery Time	$I_F=15\text{A}, di/dt=100\text{A}/\mu\text{s}$		t_{rr}	-	35	-	ns
Body Diode Reverse Recovery Charge			Q_{rr}	-	53	-	nC

Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
2. EAS condition : $T_J=25^\circ\text{C}, V_{DD}=30\text{V}, V_G=10\text{V}, L=0.5\text{mH}, R_g=25\Omega, I_{AS}=6.1\text{A}$
3. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 0.5\%$

Typical Performance Characteristics



Figure 1: Output Characteristics

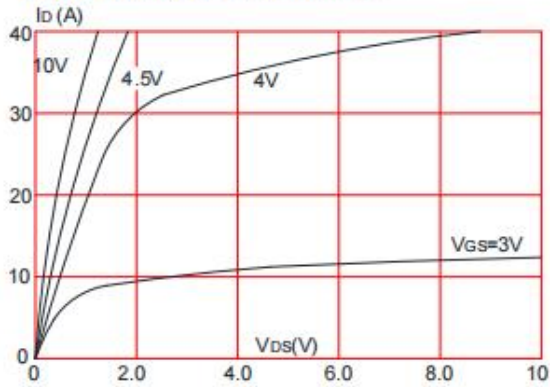


Figure 2: Typical Transfer Characteristics

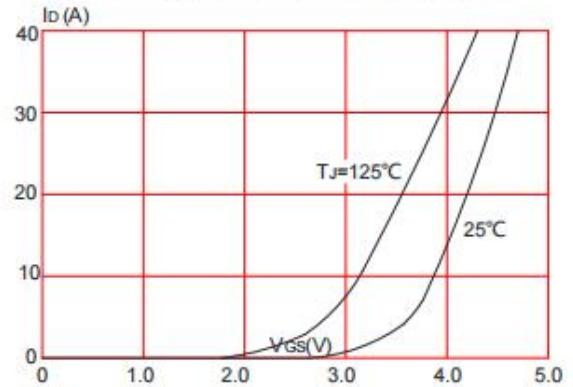


Figure 3: On-resistance vs. Drain Current

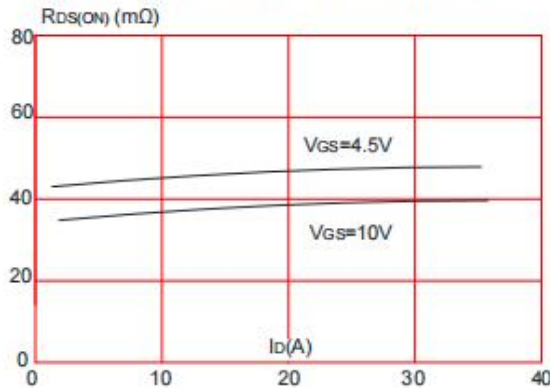


Figure 4: Body Diode Characteristics

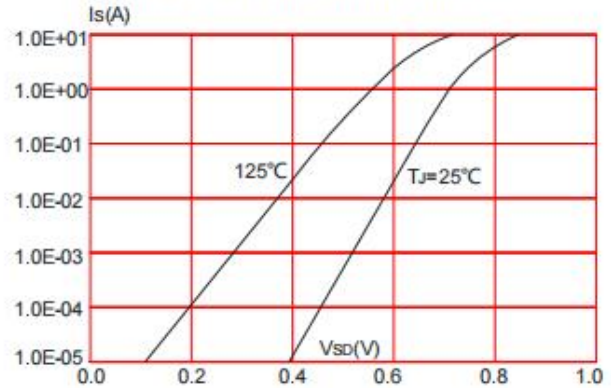


Figure 5: Gate Charge Characteristics

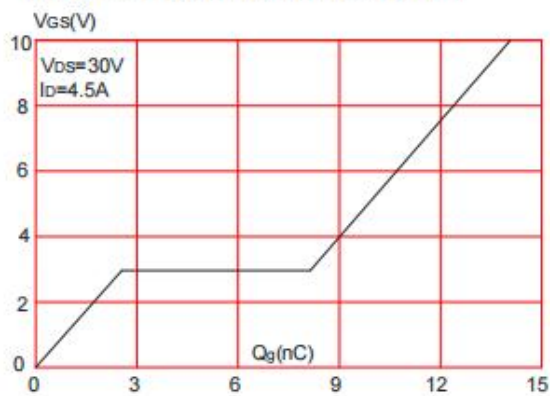


Figure 6: Capacitance Characteristics

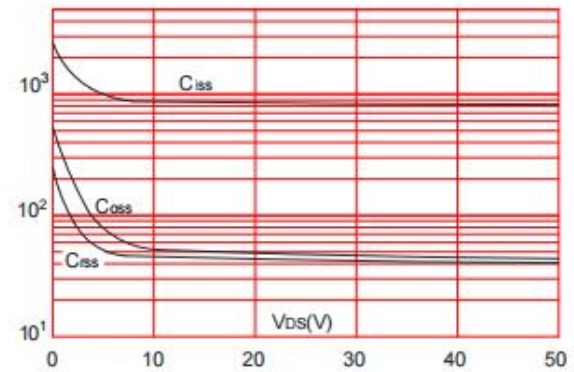




Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

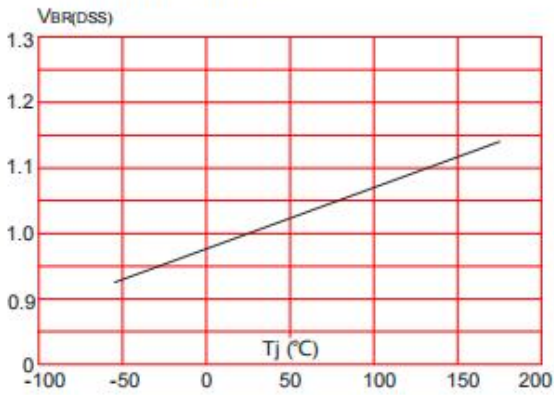


Figure 8: Normalized on Resistance vs. Junction Temperature

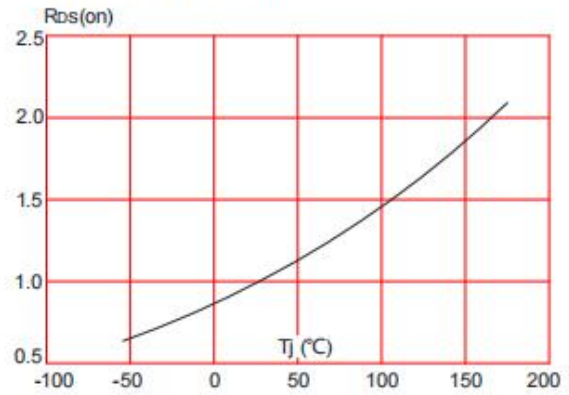


Figure 9: Maximum Safe Operating Area

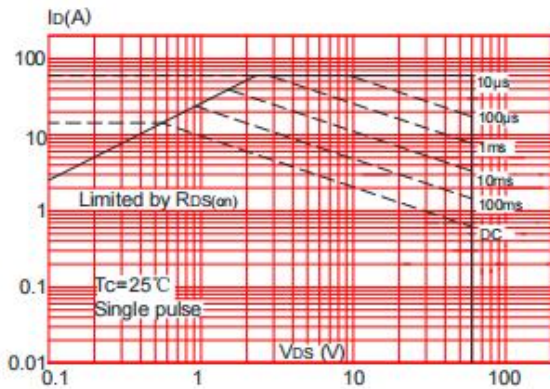


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

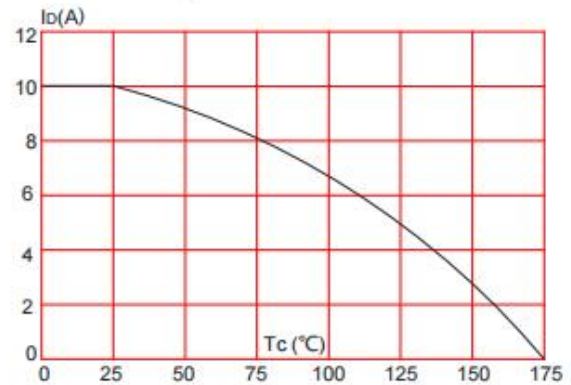
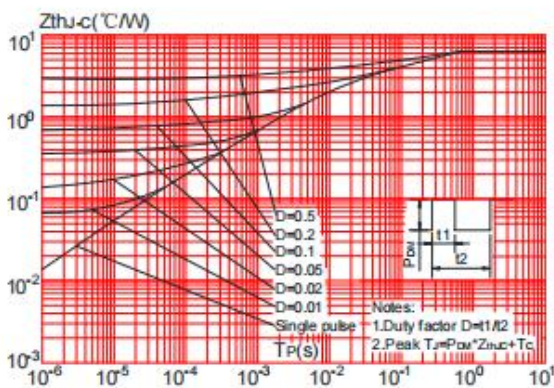
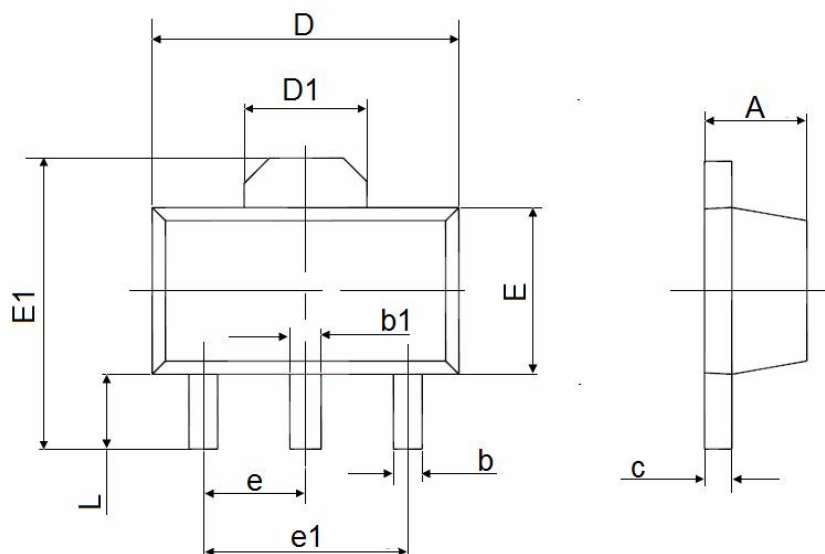


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case



Package Dimensions SOT89-3L



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.400	1.600	0.055	0.063
b	0.320	0.520	0.013	0.020
b1	0.400	0.580	0.016	0.023
c	0.350	0.440	0.014	0.017
D	4.400	4.600	0.173	0.181
D1	1.550 REF.		0.061 REF.	
E	2.300	2.600	0.091	0.102
E1	3.940	4.250	0.155	0.167
e	1.500 TYP.		0.060 TYP.	
e1	3.000 TYP.		0.118 TYP.	
L	0.900	1.200	0.035	0.047



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